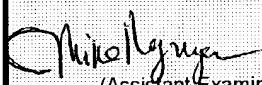
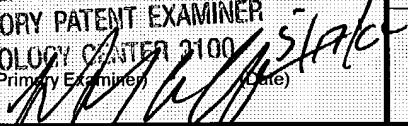
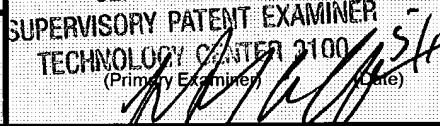


Issue Classification 	Application No.		Applicant(s)	
	09/998,738		ODENWALD, LOUIS	
	Examiner		Art Unit	
	Mike Nguyen		2182	

ORIGINAL				CROSS REFERENCE(S)							
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
710		38		710	8	9	41				
INTERNATIONAL CLASSIFICATION				709	217	218	219	239	240		
G	0	6	F	3/00							
				/							
				/							
				/							
				/							
 (Assistant Examiner)  (Date)				JEFFREY GAFFIN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 (Primary Examiner)  (Date)				Total Claims Allowed: 12			
(Legal Instruments Examiner)  (Date)								O.G. Print Claim(s)		O.G. Print Fig	
								1		2	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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4	13	34	64	94	124	154	184
5	14	35	65	95	125	155	185
6	15	36	66	96	126	156	186
7	16	37	67	97	127	157	187
8	17	38	68	98	128	158	188
9	18	39	69	99	129	159	189
10	19	40	70	100	130	160	190
11	20	41	71	101	131	161	191
12	21	42	72	102	132	162	192
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23		44	74	104	134	164	194
24		45	75	105	135	165	195
25		46	76	106	136	166	196
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